

<b>Notice of References Cited</b>	Application/Control No. 10/609,142	Applicant(s)/Patent Under Reexamination ZAIKIN ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-			
	C	US-			
	D	US-			
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#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	W.-S. Choong et al., "A Compact 16-Module Camera Using 64-Pixel CsI(Tl)/Si P-I-N Photodiode Imaging Modules." IEEE Transactions on Nuclear Science, Vol. 49, No. 5, October 2002, pp. 2228-2235.
	V	G. J. Gruber et al., "A Compact 64-Pixel CsI(Tl)/Si PIN Photodiode Imaging Module With IC Readout." IEEE Transactions on Nuclear Science, Vol. 49, No. 1, February 2002, pp. 147-152.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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